

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)

APPLICANT

SEPPO KERONEN, ET AL.

SEP 17 2002

FILING DATE October 8, 1999

GROUP 2876

PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>SLP</i>	5,434,395	7/18/95	Storck, et al.	235	380	
<i>SLP</i>	5,594,493	1/14/97	Nemirofsky	348	13	
<i>SLP</i>	5,412,416	5/2/95	Nemirofsky	348	10	
<i>SLP</i>	6,223,348	4/24/01	Hayes, et al.	725	152	
<i>SLP</i>	5,583,539	12/10/96	Hiketa, et al.	348	10	
<i>SLP</i>	5,479,205	12/26/95	Silverbrook	348	239	
<i>SLP</i>	5,353,016	10/4/94	Kurita, et al.	340	825	
<i>SLP</i>	2001-0017616	2/28/01	Kobayashi	345	173	

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
<i>SLP</i>	9520294	1/14/97	PCT/WO			
<i>SLP</i>	3,637,684	5/7/87	Germany			
<i>SLP</i>	1,039,772	9/27/00	Europe			
<i>SLP</i>	606,287	7/24/94	Europe			
<i>SLP</i>	2,696,888	4/15/94	France			
<i>SLP</i>	123,986	7/17/84	Japan			

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER

James J. Pinnerman

DATE CONSIDERED

11/24/2002

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.